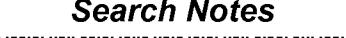


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/829,145	WU, YUH-CHERNG	
	Examiner	Art Unit	
	Jinhee J. Lee	2174	

## **Search Notes**



**Application/Control No.**

10/829,145

**Examiner**

Jinhee J. Lee

**Applicant(s)/Patent under  
Reexamination**

WU, YUH-CHERNG

## **Art Unit**

2174

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>715</b>	<b>as above</b>	12/23/2007	<b>LEE</b>

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**